



# HT series

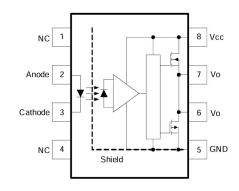
Photo Coupler Product Specification

HT-3150



## ■ Package





A 0.1µF bypass Capacitor must be connected between Pin 5 and 8.

## **■** Description

The HT-3150 consists of an infrared light emitting diodes and integrated high gain, high-speed photo detectors. The device is housed in a 8 pin DIP package. The photo detector has an internal shield that provides guaranteed common-mode transient immunity of ±15 kV/µs. It is suitable for direct gate driving circuit for IGBTs or power MOSFETs.

### **■** Features

- Rail-to-rail output voltage
- Guaranteed performance from -40 to 110℃
- Peak Output Current : Iop = 1A (max)
- Threshold Input Current: IFLH = 5 mA (max)
- High isolation voltage between input and output (Viso=5000 V rms.)
- Pb free and RoHS compliant.
- UL and cUL approved
- VDE approved
- CQC approved

# **■** Applications

- Isolated IGBT/Power MOSFET Gate Driver
- Uninterruptible power supply
- Inverters
- Home appliances, such as fan heaters, etc.



## **■ Product Nomenclature**

The product name is designated as below:

<u>HT -3150</u> -X X- X X- <u>XX</u>

1 2 3 4 5

Designation:

HT =Hengtuo Technology Co.,LTD.

3120= Product Series

- ① = Lead form option(S1,M,NONE)(1)
- ② = Tape and Reel option(TP,TP1,NONE)<sub>(2)</sub>
- ③ = VDE order option(fixed code "V")
- ④ = Halogen free option(fixed code"G")
- ⑤ = Customer code

#### **Notes**

1. Lead form option:

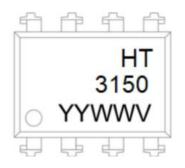
1. Load for	1. Load form option.				
Symbol	Description				
S1	DIP8-S1				
М	DIP8-M				
NONE	DIP8 Normal				

2. Tape and Reel option:

Symbol	Description
TA&TA1	Tape and Reel Type
NONE	DIP Type



# ■ Marking Information



### Designation:

HT denotes Hengtuo
3150 denotes Device
YY denotes year code
WW denotes week code
V denotes VDE

Maximum Ratings

<u> </u>								
	Parameter	Symbol	Values	Unit				
	Forward Current	l <sub>F</sub>	20	mA				
Input	Pulse Forward Current <sup>(1)</sup>	I <sub>FP</sub>	1	Α				
	Reverse voltage	$V_R$	5	V				
	"H" Peak Output current	I <sub>OPH</sub>	1	Α				
Output	"L" Peak Output Current	I <sub>OPL</sub>	1	Α				
Output	Pear Output Voltage	Vo	30	V				
	Supply Voltage	V <sub>CC</sub> -V <sub>EE</sub>	15 to 30	V				
Operating frequency		f	50	kHz				
Isolation voltage <sup>(2)</sup>		V <sub>ISO</sub>	5000	Vrms				
Total Power Dissipation		P <sub>T</sub>	300	mW				
Operating temperature		$T_OPR$	<b>−40 ~110</b>	°C				
Storage temperature		$T_{STG}$	<b>−</b> 55 ~ 125	°C				
Soldering temperature <sup>(3)</sup>		T <sub>SOL</sub>	260	°C				

#### Notes:

- (1). Pulse width  $\leq 1 \mu s$ , 300 pps.
- (2).AC for 1 minute, R.H.=  $40 \sim 60\%$  R.H. In this test, pins 1, 4 are shorted together, and pins 5, 8 are shorted together.
- (3).For 10 seconds.



# ■ Electronic Optical Characteristics (TA = 25°C)

P	arameter	Symbol	Min.	Тур.	Max.	Unit	Conditon
	Forward Voltage	V <sub>F</sub>	1,2	1.34	1.8	V	I <sub>F</sub> =10mA
	Reverse Current	V <sub>R</sub>	-	-	5	V	I <sub>R</sub> =10uA
Input	Input Threshold Current	I <sub>FLH</sub>	-	1.4	5	mA	V <sub>CC</sub> =30V,V <sub>O</sub> > 5V
	Input Threshold Voltage	V <sub>FHL</sub>	0.8	-	-	V	V <sub>CC</sub> =30V,V <sub>O</sub> < 5V
	High level supply current	Іссн	-	1.8	3.0	mA	$I_F$ =10mA, $V_{CC}$ =30V, $V_O$ =Open
	Low level supply current	Iccl	-	2.0	3.0	mA	$I_F$ =0mA, $V_{CC}$ =30V, $V_{O}$ =Open
	High Level Output		_	-	-0.3	٨	Vo=Vcc-1.5V
	Current <sup>(4)</sup>	Іон	-	-	-0.8	A	Vcc-Vo≤15V
	Low Level Output Current <sup>(4)</sup>	I <sub>OL</sub>	0.3	-	-	Α	V <sub>0</sub> =V <sub>CC</sub> +2.5V
Output			0.8	-	-		V <sub>CC</sub> -V <sub>EE</sub> ≪ 15V
	High Level Output Voltage	V <sub>OH</sub>	V <sub>CC</sub> -0.25	V <sub>CC</sub> -0.1	-	V	$I_F$ =10mA, $V_{CC}$ =30V, $I_O$ =-100mA
	Low Level Output Voltage	V <sub>OL</sub>	-	V <sub>EE</sub> +0.1	V <sub>EE</sub> +0.25	V	$I_F$ =10mA, $V_{CC}$ =30V, $I_O$ =-100mA
	Under Voltage Lockout Threshold	V <sub>UVLO+</sub>	11	12.7	13.5	V	I <sub>F</sub> =10mA, V <sub>O</sub> >5V
	Under Voltage Lockout Threshold	V <sub>UVLO-</sub>	9	11.3	12.5	V	$I_F$ =10mA, $V_O$ <5V
Transfer Characte ristics	Propagation delay time to output High level	t <sub>PLH</sub>	100	240	400	ns	I <sub>F</sub> =7-16mA, V <sub>CC</sub> =15 or 30V,
	Propagation delay time to output Low level	t <sub>PHL</sub>	100	182	400	ns	$C_G$ =10nF, $R_G$ =10 $\Omega$ ,
	Pulse width distortion	t <sub>PHL</sub> -t <sub>PLH </sub>	-	-	100	ns	F=10kHz, T <sub>A</sub> =25°C
	Propagation Delay Skew <sup>(5)</sup>	t <sub>PSK</sub>	4/15	-	150	ns	Duty Cycle=50%



Output rise time	t <sub>R</sub>	-	80	-	ns	
Output fall time	t <sub>F</sub>	-	80	-	ns	
Common Mode Transient Immunity at Logic High <sup>(6)</sup>	СМн	15	-	-	kV/uS	$I_F$ =10 to 16mA, $V_{CC}$ =30V, $T_A$ =25°C $V_{CM}$ =1500V
Common Mode Transient Immunity at Logic Low <sup>(7)</sup>	CML	15	-	-	kV/uS	$I_F$ =0mA, $V_{CC}$ =30V, $T_A$ =25°C $V_{CM}$ =1500V

#### Notes:

- (4) Max. pulse width=10µs, max. duty cycle =1%
- (5)Propagation delay skew is defined as the difference between the largest and smallest propagation delay times (i.e. tPhL or tPLH) of multiple samples. Evaluations of these samples are conducted under identical test conditions (supply voltage, input current, temperature, etc).
- (6)Common mode transient immunity at output high is the maximum tolerable negative dv/dt on the trailing edge of the common mode impulse signal, V<sub>CM</sub>, to assure that the output will remain high (i.e. Vo>15.0V)
- (7) Common mode transient immunity at output low is the maximum tolerable positive dv/dt on the leading edge of the common mode pulse signal,  $V_{CM}$ , to assure that the output will remain low (i.e.  $V_{O}$ <1.0V)



## **■** Characteristics Curves

Fig.1 High Output Rail Voltage vs Ambient Temperature

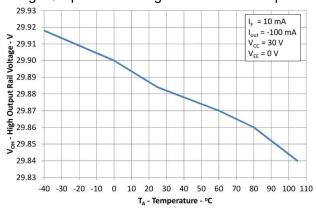


Fig.2 V<sub>OH</sub> vs Ambient Temperature

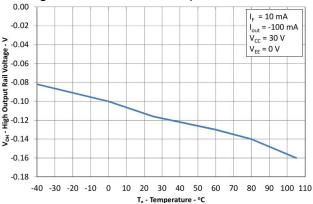


Fig.3 Vol. Voltage vs Ambient Temperature

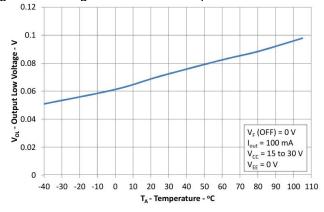


Fig.4 Supply Current vs. Ambient Temperature

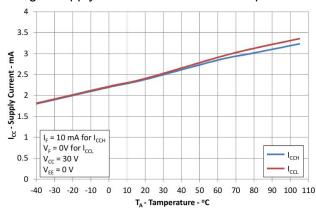


Fig.5 Supply Current vs Supply Voltage

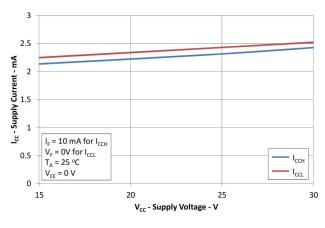


Fig.6 Output Voltage vs Threshold Input Current Low to High

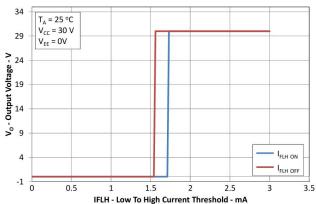




Fig.7 Threshold Input Current Low to High vs Ambient

Temperature 4.5 4 I<sub>FLH</sub> - Low To High Current 3.5 **Threshold - mA**2.5

2.5

1.5 1  $V_{cc} = 15 \text{ to } 30V$ 0.5  $V_{EE} = 0V$ 0 -40 -20 80 100 120 20 40 60 T<sub>A</sub> - Ambient Temperature - °C

Fig.8 Propagation Delay vs Supply Voltage

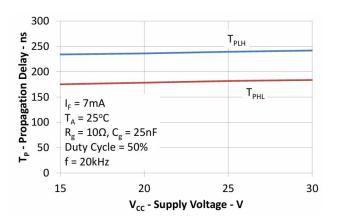


Fig.9 Propagation Delay vs Forward Current

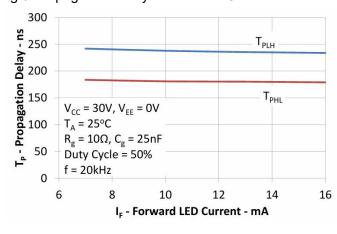


Fig.10 Propagation Delay vs Ambient Temperature

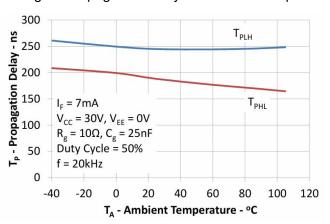
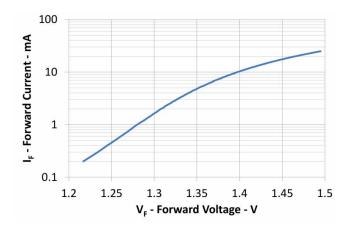


Fig.11 Forward Current vs Forward Voltage





# ■ Test Circuits Diagrams

Fig.12 lo∟ Pulsed Test Circuit

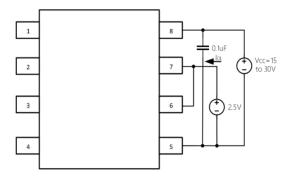


Fig.13 Іон Pulsed Test Circuit

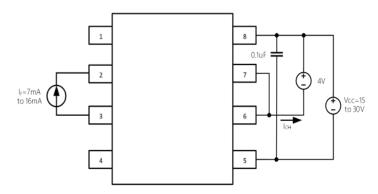


Fig.14 VoH Pulsed Test Circuit

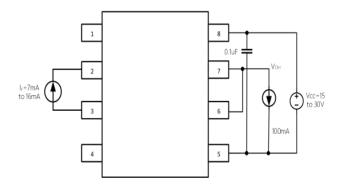


Fig.15 Vol Pulsed Test Circuit

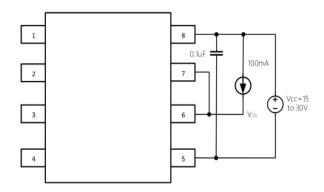


Fig.16 IFLH Test Circuit

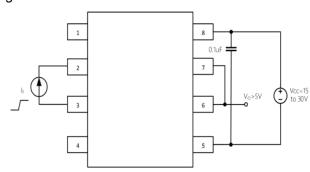


Fig.17 UVLO Test Circuit

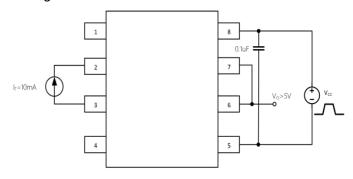




Fig.18 TPHL, TPLH, TR, TF Test Circuit

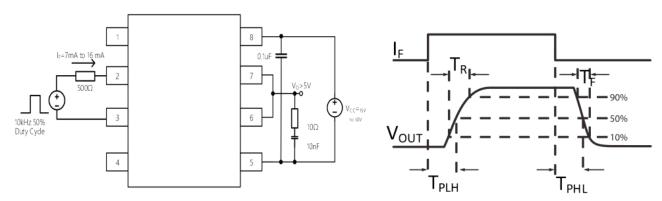
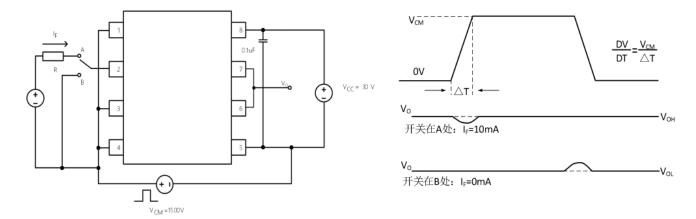


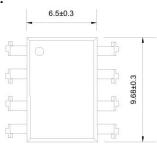
Fig.19 CMR Test Circuit

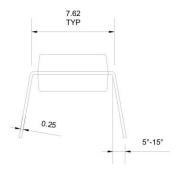


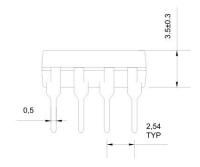


# **■ Outline Dimension**

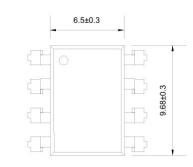
# DIP Normal Type:

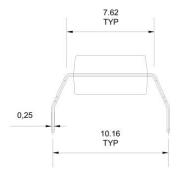


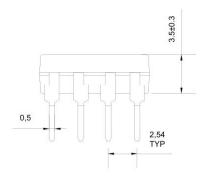




# DIP M Type:

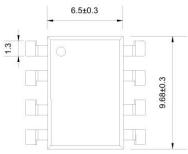


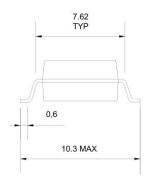


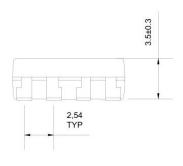


SMD S1 Type:







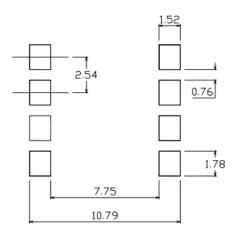


Unit: mm

Tolerance: ±0.1mm

# ■ Recommended solder pad Design

For S1 type:



Unit: mm

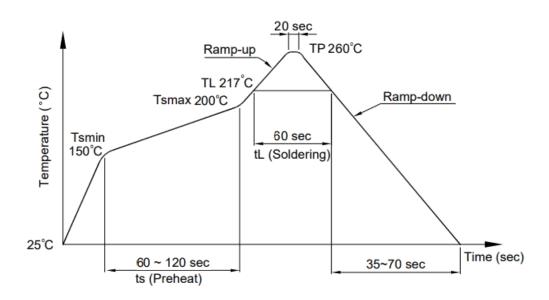
Tolerance: ±0.1mm



# **■ Temperature Profile Of Soldering**

# 1. IR Reflow soldering (JEDEC-STD-020 compliant)

Profile item	Conditon
Preheat -Temperature Min (TSmin) -Temperature Max (TSmax) -Time (min to max) (ts)	150°C 200°C 90±30 sec
Soldering zone -Temperature (TL) -Time (tL)	217°C 60 sec
Peak Temperature (TP)	260°C
Ramp-up rate	3°C / sec max
Ramp-down rate	3~6°C/ sec

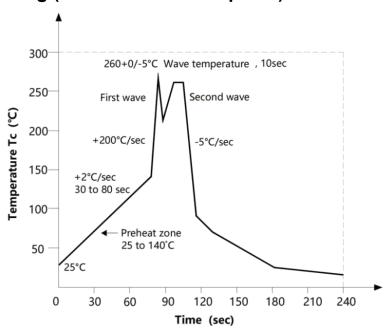


#### Notes:

One time soldering reflow is recommended within the condition of temperature and time profile shown below. Do not solder more than three times.



## 2. Wave soldering (JEDEC22A111 compliant)



#### 3. Hand soldering by soldering iron

Allow single lead soldering in every single process. One time soldering is recommended.

Temperature: 380+0/-5°C

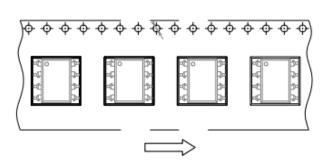
Time: 3 sec max.

# ■ Packing

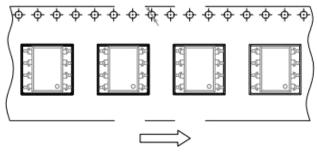
**Tape and Reel** 

**Option TA1:** 



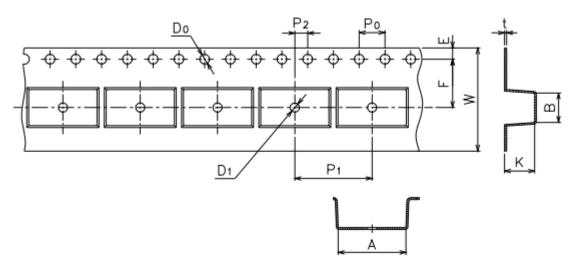


Direction of feed from reel



Direction of feed from reel





Deminsion/mm	Α	В	Do	D1	E	F
Packagetype:S	10.4±0.1	10.0±0.1	1.5+0.1/-0	1.5±0.25/-0	1.75±0.1	7.5±0.1

Deminsion/mm	Ро	P1	P2	t	W	K
Packagetype:S	4.0±0.1	12.0±0.1	2.0±0.05	0.4±0.05	16.0±0.3/	4.5±0.1

Part Number	Package Type	Packing Type	Reel	Inner carton	Outer carton
HT-3150-S1TA 1/HT-3150-S1T A	DIP-8L-S 1	Tape and reel	1K/reel	2K(2 reels)	20K
HT-3150/HT-3 150-M	DIP-8L/D IP-8L-M	Tube	45/Tube	2.25K(50 tubes)	22.5K



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- Hengtuo is continually improving the quality, reliability, function or design and Hengtuo reserves the right to make changes without further notices.
- The products shown in this publication are designed for the general use in electronic applications such as office automation equipment, communications devices, audio/visual equipment, electrical application and instrumentation.
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- When requiring a device for any "specific" application, please contact our sales in advice.
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